# International Rectifier

- Generation V Technology
- Ultra Low On-Resistance
- Dual N-Channel Mosfet
- Surface Mount
- Available in Tape & Reel
- Dynamic dv/dt Rating
- Fast Switching
- Lead-Free

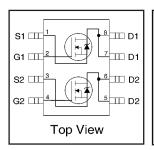
#### Description

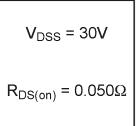
Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

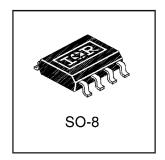
The SO-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.

# IRF7303PbF

HEXFET® Power MOSFET







#### **Absolute Maximum Ratings**

	Parameter	Max.	Units		
I <sub>D</sub> @ T <sub>A</sub> = 25°C	10 Sec. Pulsed Drain Current, V <sub>GS</sub> @ 10V	5.3			
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	4.9			
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	3.9	A		
I <sub>DM</sub>	Pulsed Drain Current ①	20			
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation	2.0	W		
	Linear Derating Factor	0.016	W/°C		
$V_{GS}$	Gate-to-Source Voltage	± 20	V		
dv/dt	Peak Diode Recovery dv/dt ②	5.0	V/ns		
$T_{J_i}T_{STG}$	Junction and Storage Temperature Range	-55 to + 150	℃		

#### **Thermal Resistance Ratings**

	Parameter	Тур.	Max.	Units
R <sub>0JA</sub>	Maximum Junction-to-Ambient⊕		62.5	°C/W

## IRF7303PbF

### Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	30			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.032		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
D	Static Drain-to-Source On-Resistance			0.050	Ω	$V_{GS} = 10V, I_D = 2.4A$ ③
R <sub>DS(ON)</sub>	Static Dialit-to-Source Off-Resistance			0.080	52	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 2.0A ③
$V_{GS(th)}$	Gate Threshold Voltage	1.0			V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
<b>g</b> fs	Forward Transconductance	5.2			S	$V_{DS} = 15V, I_D = 2.4A$
1	Drain to Source Leakage Current			1.0		$V_{DS} = 24V, V_{GS} = 0V$
IDSS	Drain-to-Source Leakage Current			25	μΑ	V <sub>DS</sub> = 24V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125 °C
lass	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 20V
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	IIA	V <sub>GS</sub> = - 20V
Qg	Total Gate Charge			25		I <sub>D</sub> = 2.4A
Q <sub>gs</sub>	Gate-to-Source Charge			2.9	nC	V <sub>DS</sub> = 24V
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge			7.9		V <sub>GS</sub> = 10V, See Fig. 6 and 12 ③
t <sub>d(on)</sub>	Turn-On Delay Time		6.8			V <sub>DD</sub> = 15V
t <sub>r</sub>	RiseTime		21			I <sub>D</sub> = 2.4A
t <sub>d(off)</sub>	Turn-Off Delay Time		22		ns	$R_G = 6.0\Omega$
t <sub>f</sub>	Fall Time		7.7			$R_D$ = 6.2 $\Omega$ , See Fig. 10 ③
L <sub>D</sub>	Internal Drain Inductance		4.0		nH	Between lead tip
L <sub>S</sub>	Internal Source Inductance		6.0		1111	and center of die contact
C <sub>iss</sub>	Input Capacitance		520			V <sub>GS</sub> = 0V
Coss	Output Capacitance		180		pF	V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		72			f = 1.0MHz, See Fig. 5

#### Source-Drain Ratings and Characteristics

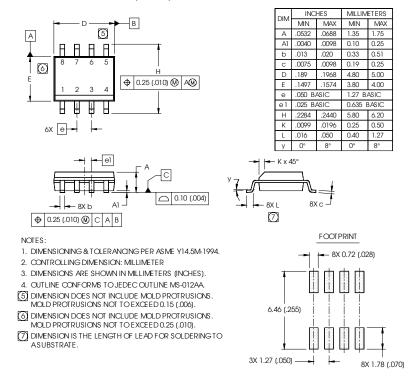
	Parameter	Min.	Тур.	Max.	Units	Conditions		
ls	Continuous Source Current			2.5		MOSFET symbol		
	(Body Diode)			_ 2.5	2.5 A	showing the		
I <sub>SM</sub>	Pulsed Source Current			20	00		A	integral reverse
	(Body Diode) ①					p-n junction diode.		
V <sub>SD</sub>	Diode Forward Voltage			1.0	V	$T_J = 25$ °C, $I_S = 1.8$ A, $V_{GS} = 0$ V ③		
t <sub>rr</sub>	Reverse Recovery Time		47	71	ns	$T_J = 25$ °C, $I_F = 2.4A$		
Q <sub>rr</sub>	Reverse RecoveryCharge		56	84	nC	di/dt = 100A/µs ③		
t <sub>on</sub>	Forward Turn-On Time	Intr	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )					

#### Notes:

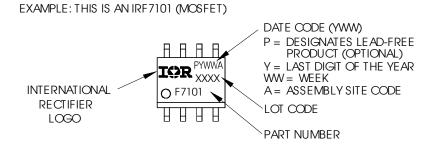
- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ③ Pulse width  $\leq$  300 $\mu$ s; duty cycle  $\leq$  2%.
- $\begin{tabular}{ll} \textcircled{2} & I_{SD} \leq 2.4A, & di/dt \leq 73A/\mu s, & V_{DD} \leq V_{(BR)DSS}, \\ & T_J \leq 150 \mbox{°C} \end{tabular}$
- 4 Surface mounted on FR-4 board,  $t \leq 10$ sec.

#### SO-8 Package Outline

Dimensions are shown in milimeters (inches)

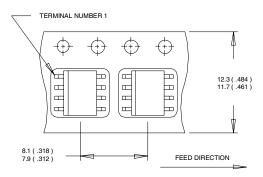


### SO-8 Part Marking Information (Lead-Free)

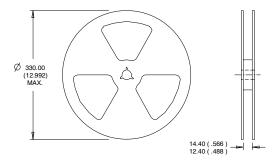


## SO-8 Tape and Reel

Dimensions are shown in milimeters (inches)



- NOTES:
  1. CONTROLLING DIMENSION : MILLIMETER.
  2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
  3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



- 1. CONTROLLING DIMENSION : MILLIMETER.
  2. OUTLINE CONFORMS TO EIA-481 & EIA-541.
  - Data and specifications subject to change without notice. This product has been designed and qualified for the Consumer market. Qualifications Standards can be found on IR's Web site.

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